

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/604,108	DOWNEY ET AL.	
Examiner	Art Unit	
Tianjie Chen	2652	

	SEARCHED				
Class	Subclass	Date	Examiner		
Updated		6/1/2005			
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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